N-Channel 650 V (D-S) 175 °C MOSFET

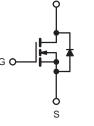
PRODUCT	SUMMAI	RY

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SEMICONDUCTOR

V _{DS} (V) at 1 _J max.	650		
R _{DS(on)} max. at 25 °C (Ω)	$V_{GS} = 10 V$	0.106	
Q _g max. (nC)	273		
Q _{gs} (nC)	46		
Q _{gd} (nC)	79		
Configuration	Single		





D

N-Channel MOSFET

FEATURES

- Low Figure-of-Merit (FOM) Ron x Qa
- Low Input Capacitance (Ciss)
- Reduced Switching and Conduction Losses
- Ultra Low Gate Charge (Q_q)
- Avalanche Energy Rated (UIS)

APPLICATIONS

- Server and Telecom Power Supplies
- Switch Mode Power Supplies (SMPS)
- Power Factor Correction Power Supplies (PFC)
- Lighting
 - High-Intensity Discharge (HID)
 - Fluorescent Ballast Lighting
- Industrial
 - Welding
 - Induction Heating
 - Motor Drives
 - Battery Chargers
 - Renewable Energy
 - Solar (PV Inverters)

ABSOLUTE MAXIMUM RATINGS ($T_c = 25 \text{ °C}$, unless otherwise noted)						
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage		V _{DS}	650			
Gate-Source Voltage		V _{GS}	± 20	V		
Gate-Source Voltage AC (f > 1 Hz)			30			
Continuous Drain Current (T _J = 150 °C)	V_{GS} at 10 V $T_C = 25 \degree C$	۱ _D	38			
	$T_{\rm C} = 100 ^{\circ}{\rm C}$		30	A		
Pulsed Drain Current ^a	I _{DM}	139				
Linear Derating Factor			3.3	W/°C		
Single Pulse Avalanche Energy ^b		E _{AS}	1410	mJ		
Maximum Power Dissipation		PD	417	W		
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 175	°C		
Drain-Source Voltage Slope	T _J = 125 °C	dV/dt	37	V/ns		
Reverse Diode dV/dt ^d		uv/di	9	v/115		
Soldering Recommendations (Peak Temperature) ^c	for 10 s		300	°C		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature.
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 28.2 mH, R_g = 25 Ω , I_{AS} = 10 A.
- c. 1.6 mm from case.
- d. $I_{SD} \leq I_D, \, dI/dt$ = 100 A/µs, starting T_J = 25 °C.



COMPLIANT





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THERMAL RESISTANCE RATI	NGS							
PARAMETER	SYMBOL	TYP.		MAX.		UNIT		
Maximum Junction-to-Ambient	R _{thJA}	- 40						
Maximum Junction-to-Case (Drain)	R _{thJC}	- 0.3				°C/W		
SPECIFICATIONS (T _J = 25 °C, u	nless otherw	ise noted)						
PARAMETER	SYMBOL	TES	T CONDIT	IONS	MIN.	TYP.	MAX.	UNIT
Static					-		-	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D =	250 µA	650	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	, I _D = 1 mA	-	0.70	-	V/°C
Gate-Source Threshold Voltage (N)	V _{GS(th)}	V _{DS} =	$V_{DS} = V_{GS}, I_D = 250 \ \mu A$		2	-	4	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20$) V	-	-	± 100	nA
		$V_{DS} = 650 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$		-	-	1		
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 520 V	/, V _{GS} = 0 ^v	V, T _J = 125 °C	-	-	25	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V		_D = 24 A	-	0.100	0.106	Ω
Forward Transconductance	9 _{fs}	V _{DS}	= 30 V, I _D	= 24 A	-	16.7	-	S
Dynamic					1		1	<u> </u>
Input Capacitance	C _{iss}		$V_{22} = 0$	1	-	5682	-	
Output Capacitance	C _{oss}	_	V _{GS} = 0 V, V _{DS} = 100 V,		-	251	-	1
Reverse Transfer Capacitance	C _{rss}	f = 1 MHz		-	1	-	pF	
Effective Output Capacitance, Energy Related ^a	C _{o(er)}	$V_{\rm DS}$ = 0 V to 520 V, $V_{\rm GS}$ = 0 V		-	192	-		
Effective Output Capacitance, Time Related ^b	C _{o(tr)}			-	665	-		
Total Gate Charge	Qg				-	182	273	
Gate-Source Charge	Q _{gs}	$V_{GS} = 10 \text{ V}$	V _{GS} = 10 V I _D = 24 A, V _{DS} = 520 V		-	46	-	nC
Gate-Drain Charge	Q_gd				-	79	-	
Turn-On Delay Time	t _{d(on)}				-	47	94	
Rise Time	t _r	$\label{eq:VDD} \begin{array}{l} V_{\text{DD}} = 520 \text{ V}, \text{ I}_{\text{D}} = 6 \text{ A}, \\ V_{\text{GS}} = 10 \text{ V}, \text{ R}_{\text{g}} = 9.1 \ \Omega \end{array}$		-	87	131	ns	
Turn-Off Delay Time	t _{d(off)}			-	156	234		
Fall Time	t _f			-	103	206		
Gate Input Resistance	R _g	f = 1 MHz, open drain		-	0.64	-	Ω	
Drain-Source Body Diode Characteristic	s	- I			1	1	1	•
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	38		
Pulsed Diode Forward Current	I _{SM}			-	-	139	A	
Diode Forward Voltage	V _{SD}	T _J = 25 °C, I _S = 24 A, V _{GS} = 0 V		-	0.9	1.2	V	
Reverse Recovery Time	t _{rr}		-		-	753	1506	ns
Reverse Recovery Charge	Q _{rr}	$T_J = 25 \text{ °C}, I_F = I_S = 24 \text{ A},$ dI/dt = 100 A/µs, $V_R = 25 \text{ V}$		-	14	28	μC	
Reverse Recovery Current				_	28	-	A	
	I _{RRM}			-	20	1 -		

Notes

a. $C_{oss(er)}$ is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} . b. $C_{oss(tr)}$ is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80 % V_{DSS} .



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

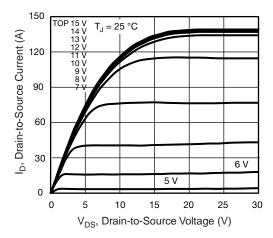


Fig. 1 - Typical Output Characteristics

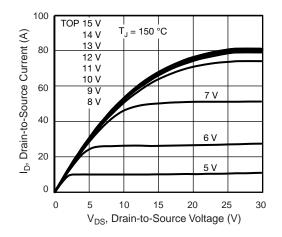


Fig. 2 - Typical Output Characteristics

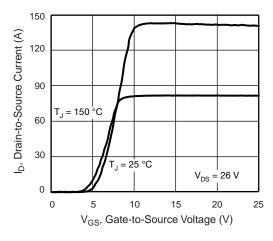


Fig. 3 - Typical Transfer Characteristics

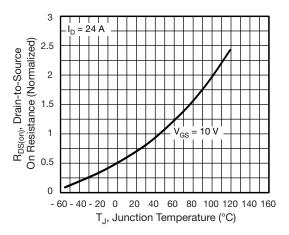


Fig. 4 - Normalized On-Resistance vs. Temperature

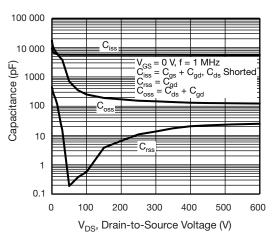


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

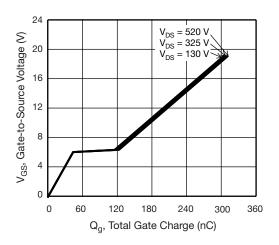
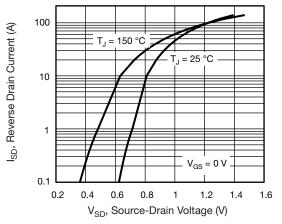


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



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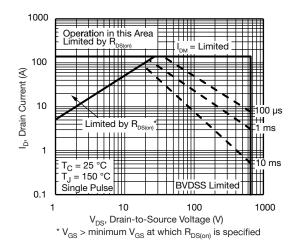


Fig. 8 - Maximum Safe Operating Area

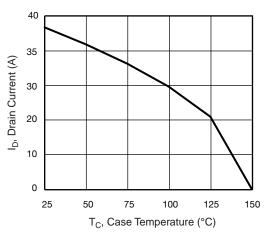


Fig. 9 - Maximum Drain Current vs. Case Temperature

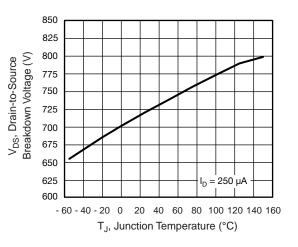


Fig. 10 - Temperature vs. Drain-to-Source Voltage

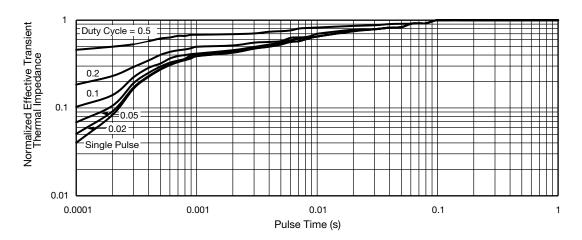


Fig. 11 - Normalized Thermal Transient Impedance, Junction-to-Case

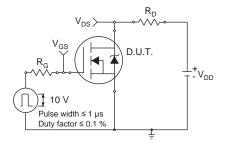


Fig. 12 - Switching Time Test Circuit

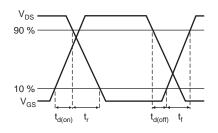


Fig. 13 - Switching Time Waveforms

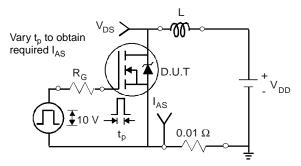


Fig. 14 - Unclamped Inductive Test Circuit

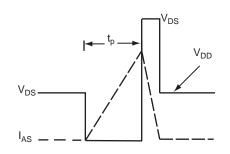


Fig. 15 - Unclamped Inductive Waveforms

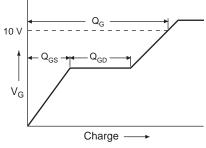


Fig. 16 - Basic Gate Charge Waveform

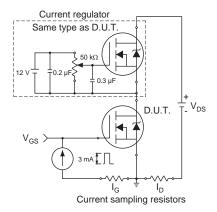
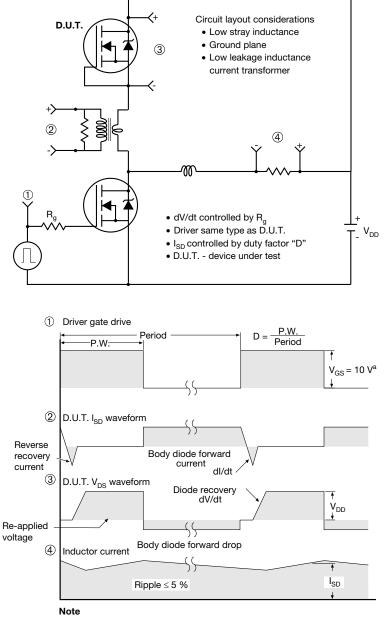


Fig. 17 - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



a. $V_{GS} = 5$ V for logic level devices

Fig. 18 - For N-Channel



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